SCAS034A - FEBRUARY 1988 - REVISED APRIL 1993

- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- *EPIC*[™] (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

description

These devices contain six independent noninverters. They perform the Boolean function Y = A.

The 54AC11034 is characterized for operation over the full military temperature range of -55° C to 125°C. The 74AC11034 is characterized for operation from -40° C to 85°C.

FUNCTION TABLE (each inverter)					
INPUT	OUTPUT				
Α	Y				
Н	Н				

logic symbol[†]

4.4	20		1	1Y
	19	1	2	
2A 2 A	18		3	2Y 3Y
1A 2A 3A 4A 5A	13		8	4Y
7 Ω	12		9	5Y
6A	11		10	6Y

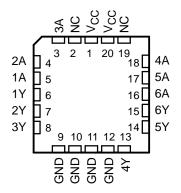
[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the DW, J, and N packages.

54AC11034	J PACKAGE
74AC11034	DW OR N PACKAGE
(TO	P VIEW)

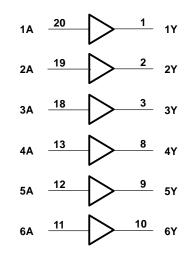
1Y 2Y 3Y GND	[1 [2 [3 [4	U 20 19 18 17] 1A] 2A] 3A] NC
GND GND	Ц4 П5	17 16	∐NC]V _{CC}
GND		15	Vcc
GND	[7	14] NC
4Y	8	13] 4A
5Y	9	12	5A
6Y	10	11] 6A

54AC11034 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	$\dots \dots -0.5$ V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	$\dots -0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Storage temperature range	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions

			54	AC1103	4	74AC11034		UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		3	5	5.5	3	5	5.5	V
		$V_{CC} = 3 V$	2.1			2.1			
VIH	High-level input voltage	$V_{CC} = 4.5 V$	3.15			3.15			V
		V _{CC} = 5.5 V	3.85			3.85			
		V _{CC} = 3 V			0.9			0.9	
VIL	Low-level input voltage	V _{CC} = 4.5 V			1.35			1.35	V
		V _{CC} = 5.5 V			1.65			1.65	1.65
VI	Input voltage		0		VCC	0		VCC	V
VO	Output voltage		0		Vcc	0		VCC	V
		$V_{CC} = 3 V$			-4			-4	
IОН	High-level output current	V _{CC} = 4.5 V			-24			-24	mA
		V _{CC} = 5.5 V			-24			-24	
		V _{CC} = 3 V			12			12	
IOL	Low-level output current	V _{CC} = 4.5 V			24			24	mA
		V _{CC} = 5.5 V			24			24	
$\Delta t/\Delta v$	Input transition rise or fall rate	-	0		10	0		10	ns/V
Т _А	Operating free-air temperature		-55		125	-40		85	°C



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		N N	Т	4 = 25°C	;	54AC	11034	74AC1	1034	LINUT
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
		3 V	2.9			2.9		2.9		
	I _{OH} = – 50 μA	4.5 V	4.4			4.4		4.4		
		5.5 V	5.4			5.4		5.4		
Vou	$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.4		2.48		V
VOH		4.5 V	3.94			3.7		3.8		v
	I _{OH} = – 24 mA	5.5 V	4.94			4.7		4.8		
	$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V				3.85				
	I _{OH} = -75 mA [†]	5.5 V						3.85		
		3 V			0.1		0.1		0.1	
	I _{OL} = 50 μA	4.5 V			0.1		0.1		0.1	
		5.5 V			0.1		0.1		0.1	
Voi	I _{OL} = 12 mA	3 V			0.36		0.5		0.44	— V
VOL	I _{OL} = 24 mA	4.5 V			0.36		0.5		0.44	
		5.5 V			0.36		0.5		0.44	
	$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V					1.65			
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V							1.65	
Ц	$V_{I} = V_{CC} \text{ or } GND$	5.5 V			±0.1		±1		±1	μΑ
lcc	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			4		80		40	μΑ
Ci	$V_I = V_{CC}$ or GND	5 V		3.5						pF

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†]Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T,	4 = 25°C	;	54AC1	11034	74AC1	1034	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	A	V	1.5	5.7	9.1	1.5	10.7	1.5	10.1	20
^t PHL		T	1.5	5.5	8.3	1.5	9.9	1.5	9.2	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

ſ	PARAMETER	FROM	то	T,	4 = 25°C	;	54AC1	1034	74AC1	1034	UNIT
	FARAINETER	(INPUT) (OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX		
[^t PLH	A	V	1.5	4	6.3	1.5	7.4	1.5	6.9	
[^t PHL		ſ	1.5	4	6.2	1.5	7.3	1.5	6.8	ns

operating characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$

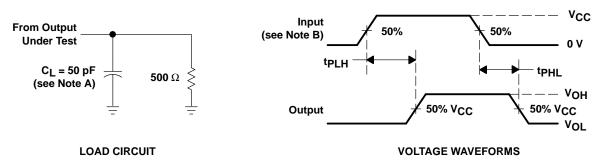
PARAMETER	TEST CONDITIONS TYP	UNIT
C _{pd} Power dissipation capacitance per gate	C _L = 50 pF, f = 1 MHz 27	pF



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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. $C_{\mbox{L}}$ includes probe and jig capacitance.
 - B. Input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_r = 3 ns, t_f = 3 ns.
 - C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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